

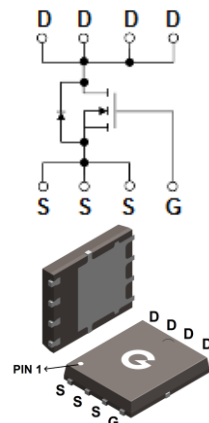
Features

- Advanced Shielded-Gate Trench technology
- Ultra low $R_{DS(ON)}$ to minimize conduction losses
- Superior thermal resistance
- HBM: JESD22-A114-B: 1B
- RoHS compliant with Halogen-free

HF

Mechanical Data

- Case: PDFN5×6-8L
- Molding Compound: UL Flammability Classification Rating 94V-0
- Terminals: Matte tin-plated leads; solderability-per MIL-STD-202, Method 208



PDFN5×6-8L

Ordering Information

Part Number	Package	Shipping Quantity	Marking Code
BLS017N03T-5DL8	PDFN5×6-8L	5000 pcs / Tape & Reel	017N03T

Maximum Ratings (@ $T_C = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-to-Source Voltage	V_{DSS}	30	V
Gate-to-Source Voltage	V_{GSS}	± 20	V
Continuous Drain Current ($T_C = 25^\circ\text{C}$, Silicon limited) ^{*1}	I_D	170	A
Continuous Drain Current ($T_C = 100^\circ\text{C}$, Silicon limited) ^{*1}		107	
Continuous Drain Current ($T_A = 25^\circ\text{C}$) ^{*2}		33	
Continuous Drain Current ($T_A = 100^\circ\text{C}$) ^{*2}		21	
Pulsed Drain Current ($t_p = 10\mu\text{s}$, $T_C = 25^\circ\text{C}$)	I_{DM}	680	A
Single Pulse Avalanche Energy ^{*3}	E_{AS}	150	mJ
Power Dissipation ($T_C = 25^\circ\text{C}$)	P_D	78	W
Power Dissipation ($T_A = 25^\circ\text{C}$) ^{*2}		3.1	
Operating Junction Temperature Range	T_J	$-55 \sim +150$	$^\circ\text{C}$
Storage Temperature Range	T_{STG}	$-55 \sim +150$	$^\circ\text{C}$

Thermal Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal Resistance Junction-to-Case	$R_{\theta JC}$	-	1.2	1.6	$^\circ\text{C/W}$
Thermal Resistance Junction-to-Air ^{*2}	$R_{\theta JA}$	-	35	40	$^\circ\text{C/W}$

Electrical Characteristics (@ $T_A = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Unit
Static Characteristics						
V _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0V, I _D = 250μA	30	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 30V, V _{GS} = 0V	-	-	1	μA
I _{GSS}	Gate-Body Leakage Current	V _{GS} = ±20V, V _{DS} = 0V	-	-	±100	nA
On Characteristics						
R _{DS(ON)}	Drain-Source On-resistance *4	V _{GS} = 10V,I _D = 30A	-	1.6	1.75	mΩ
		V _{GS} = 4.5V,I _D = 20A	-	2.6	3.5	mΩ
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250μA	1	1.7	2.5	V
R _G	Gate Resistance	V _{GS} = 0V, f = 1MHz	-	2.7	-	Ω
Dynamic Characteristics						
C _{ISS}	Input Capacitance	V _{GS} = 0V	-	2105	-	pF
C _{OSS}	Output Capacitance	V _{DS} = 15V	-	973	-	
C _{RSS}	Reverse Transfer Capacitance	f = 300kHz	-	52	-	
Switching Characteristics						
t _{d(ON)}	Turn-on Delay Time *5	V _{DD} = 15V V _{GS} = 10V I _D = 30A R _G = 5Ω	-	18	-	ns
t _r	Turn-on Rise Time *5		-	55	-	
t _{d(OFF)}	Turn-Off Delay Time *5		-	47	-	
t _f	Turn-Off Fall Time *5		-	28	-	
Q _G	Total Gate-Charge(V _{GS} = 4.5V)	V _{DD} = 15V, I _D = 30A	-	16.2	-	nC
	Total Gate-Charge	V _{DD} = 15V	-	33.3	-	
Q _{GS}	Gate to Source Charge	V _{GS} = 10V	-	6.2	-	
Q _{GD}	Gate to Drain (Miller) Charge	I _D = 30A	-	5.8	-	
Source-Drain Diode Characteristics						
V _{SD}	Diode Forward Voltage *4	I _S = 30A, V _{GS} = 0V	-	0.8	1.2	V
t _{rr}	Reverse Recovery Time	I _S = 30A, V _{GS} = 0V	-	100	-	ns
Q _{rr}	Reverse Recovery Charge	di/dt = 100A/μs	-	110	-	nC

Notes:

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted. De-rating will be required based on the actual environmental conditions
- The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper
- The E_{AS} data shows Max. rating. The test condition is $V_{DD} = 20V, V_{GS} = 10V, L = 0.5mH$
- The data tested by pulsed, pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$
- Guaranteed by design, not subject to production

Ratings and Characteristics Curves (@ $T_A = 25^\circ\text{C}$ unless otherwise specified)

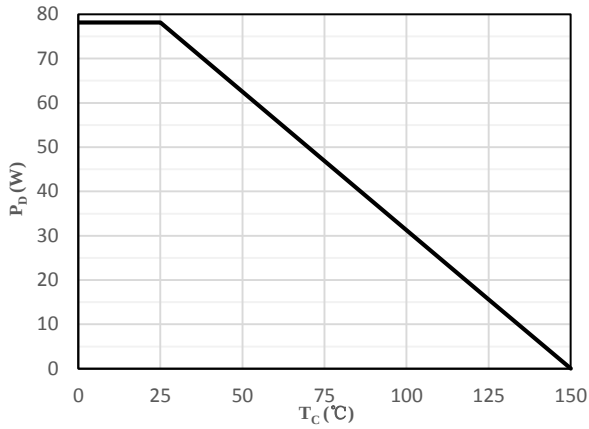


Fig 1 Power Dissipation

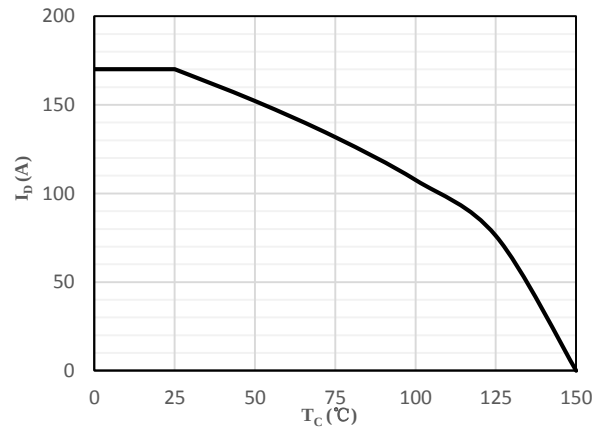


Fig 2 Drain Current

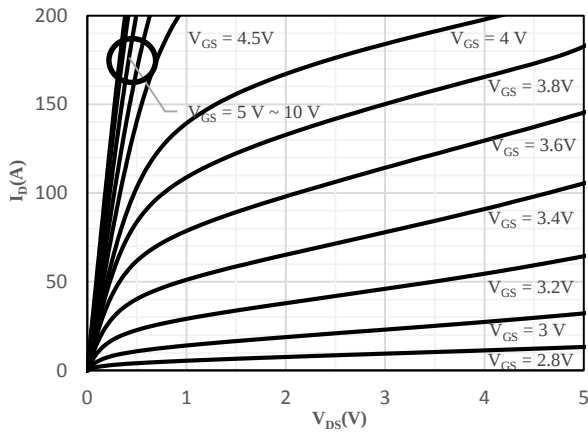


Fig 3 Typical Output Characteristics

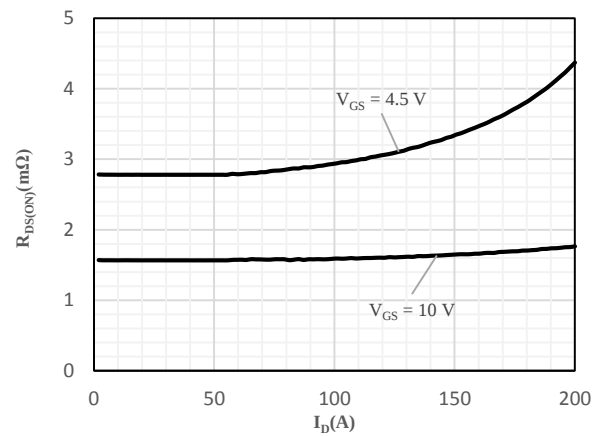


Fig 4 On-Resistance vs. Drain Current and Gate Voltage

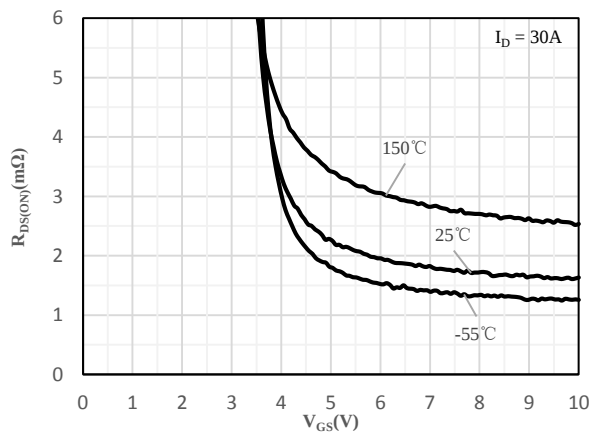


Fig 5 On-Resistance vs. Gate-Source Voltage

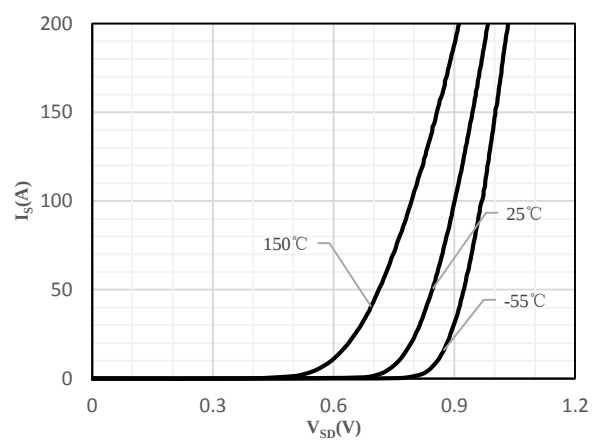


Fig 6 Body-Diode Characteristics

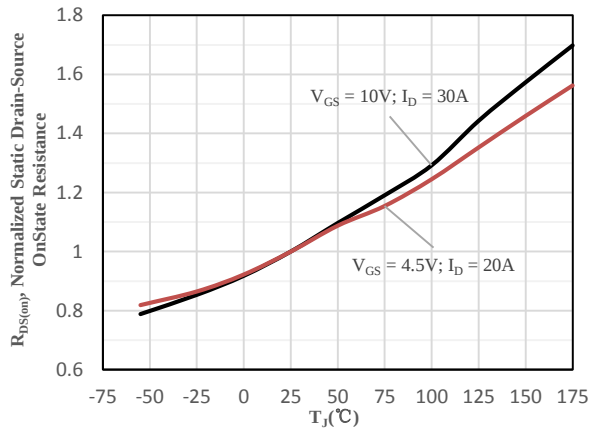


Fig 7 Normalized On-Resistance vs. Junction Temperature

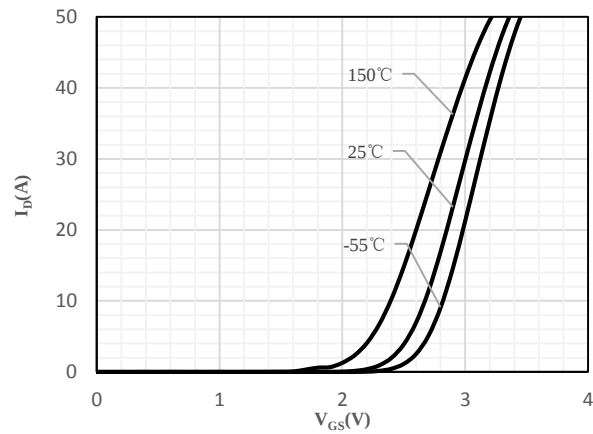


Fig 8 Transfer Characteristics

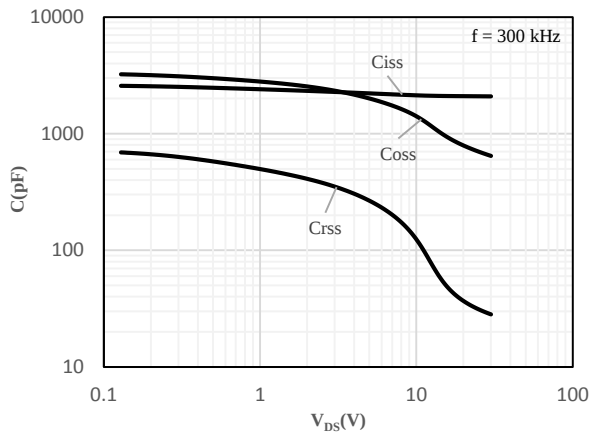


Fig 9 Capacitance Characteristics

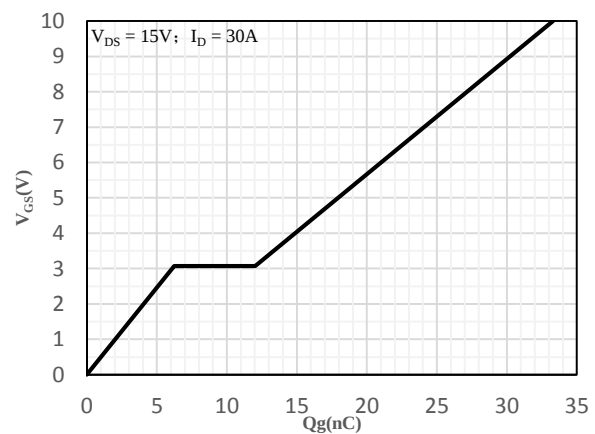


Fig 10 Gate-Charge Characteristics

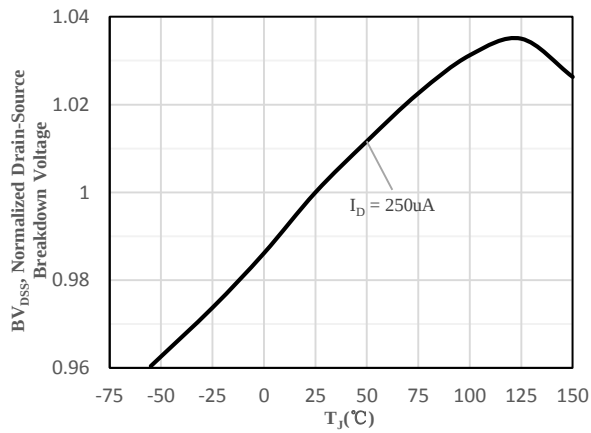


Fig 11 Normalized Breakdown Voltage vs. Junction Temperature

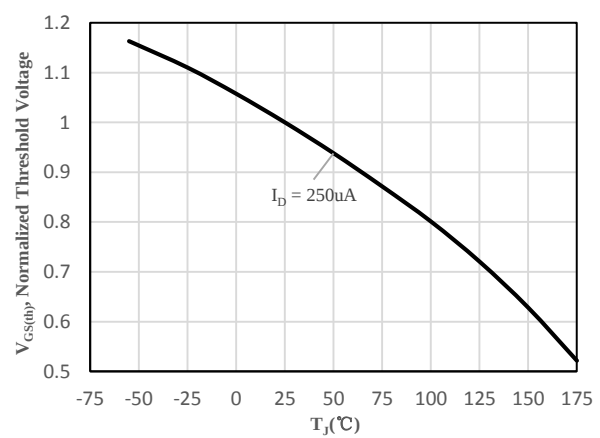
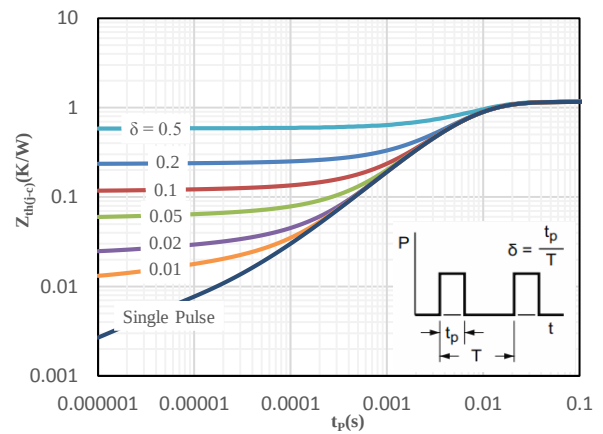
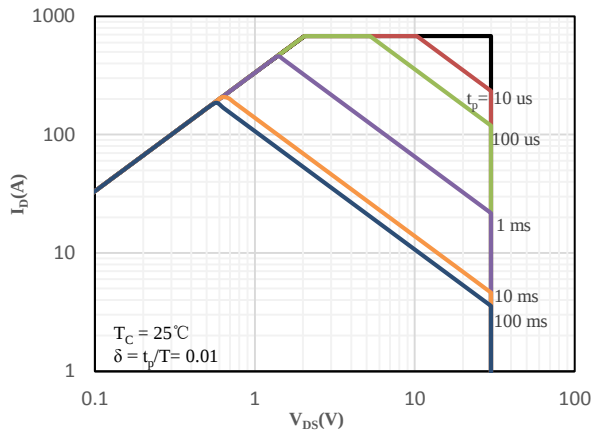
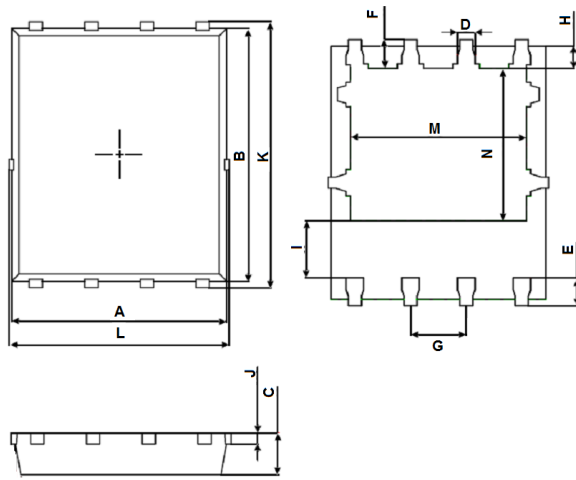


Fig 12 Normalized $V_{GS(th)}$ vs. Junction Temperature



Package Outline Dimensions (Unit: mm)



PDFN5×6-8L		
Dimension	Min.	Max.
A	4.824	4.976
B	5.674	5.826
C	0.900	1.000
D	0.350	0.450
E	0.559	0.711
F	0.574	0.726
G	1.250	1.290
H	0.424	0.576
I	1.190	1.390
J	0.154	0.354
K	5.974	6.126
L	4.944	5.096
M	3.910	4.110
N	3.375	3.575

Mounting Pad Layout (Unit: mm)

PDFN5×6-8L

